

# Search Notes



Application/Control No.

10/526,565

Examiner

Pablo N. Tran

Applicant(s)/Patent under Reexamination

NAGHIAN, SIAMAK

Art Unit

2618

## SEARCHED

Class	Subclass	Date	Examiner
370	238	07/28/07	PL
	338		
	252		
	254		
	255		
	306		
	386		
	229		
	230		
	235		
	256		
	310.1-313		
	389-393		
	432		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
East/West	07/28/07	PL

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Pablo N. Tran

2618

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

[illegible]